

Date: \_\_\_\_\_



**INDIAN INSTITUTE OF TECHNOLOGY, BOMBAY**  
**IR-Atomic Force Microscopy (IR-AFM)**

**Email: [irafmcsif@gmail.com](mailto:irafmcsif@gmail.com)**

**REGISTRATION FORM FOR INTERNAL/EXTERNAL USERS**

- 1) Name of the User:
- 2) Name of the Department:
- 3) Supervisor name:
- 4) Email and Tel No:
- 5) Number of samples (Maximum 3):
- 6) Specifications of samples: Material(s) and Substrate (if any)
- 7) Nature of sample (Hard/Soft, Dry/Wet):
- 8) Mode of AFM (Contact/Tapping/Others):
- 9) Scan size required:
- 10) Any other remarks:

MATERIAL IS NOT POISONOUS/TOXIC IN ANY WAY (Please provide MSDS data sheet)

*We agree to acknowledge the IR-AFM Central Facility of IIT BOMBAY in our Publications / Reports / Thesis in which the data is used with due feedback through email.*

Signature of the User: \_\_\_\_\_

Note: Samples should be brought by the user at the allotted time and the user should be present while the samples are being examined